

General Description

The WSP6946 is the highest performance trench N-ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSP6946 meet the RoHS and Green Product requirement , 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

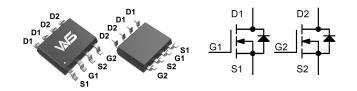
Product Summery

BVDSS	RDSON	ID
60V	43 m Ω	6.5A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOP-8 Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	6.5	Α
I _D @T _C =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	4.5	А
I _{DM}	Pulsed Drain Current ²	24	Α
EAS	Single Pulse Avalanche Energy ³	12	mJ
I _{AS}	Avalanche Current	16	Α
P _D @T _A =25°C	Total Power Dissipation⁴	2.5	W
T _{STG}	T _{STG} Storage Temperature Range -55 to 150 T _J Operating Junction Temperature Range -55 to 150		$^{\circ}$
TJ			$^{\circ}$

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
$R_{ heta JA}$	Thermal Resistance Junction-ambient ¹		90	°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		50	°C/W

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Electrical Characteristics (T_J=25 ℃, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.044		V/°C
В	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =6.3A		43	52	m()
R _{DS(ON)}	Static Dialii-Source On-Resistance	V _{GS} =4.5V , I _D =4A		46	60	mΩ
V _{GS(th)}	Gate Threshold Voltage	V -V 1 -250A	1.0	2.0	3.0	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250uA$		-4.8		mV/℃
,	Dunin Course Lookers Course	V _{DS} =48V , V _{GS} =0V , T _J =25℃			1	
I _{DSS}	Drain-Source Leakage Current	V_{DS} =48V , V_{GS} =0V , T_J =55 $^{\circ}\mathrm{C}$			5	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =4A		28.3		S
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		2.5	5	Ω
Qg	Total Gate Charge (10V)			14	20	
Q_{gs}	Gate-Source Charge	V _{DS} =48V , V _{GS} =10V , I _D =6.3A		2.6		nC
Q_{gd}	Gate-Drain Charge			2.2		
T _{d(on)}	Turn-On Delay Time			8	15	
Tr	Rise Time	V_{DD} =30V , V_{GEN} =10V , R_G =6 Ω		6	11	
T _{d(off)}	Turn-Off Delay Time	I_D =4A ,RL=30 Ω		23	42	ns
T _f	Fall Time			6	11	1
C _{iss}	Input Capacitance			870		
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		70		pF
C _{rss}	Reverse Transfer Capacitance			35		

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V , L=0.1mH , I _{AS} =12A	10			mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}	V =V =0V Force Current			2.5	Α
I _{SM}	Pulsed Source Current ^{2,6}	V _G =V _D =0V , Force Current			24	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25℃			1.1	V
t _{rr}	Reverse Recovery Time			20		nS
Qrr	Reverse Recovery Charge	l⊧=6.3A , dl/dt=100A/μs , T _J =25℃		18		nC

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, t<10 sec.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3.The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =12A
- 5.The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

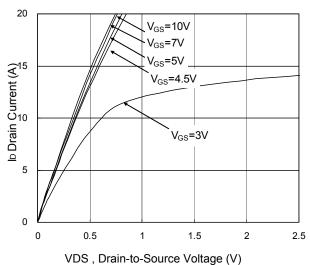


Fig.1 Typical Output Characteristics

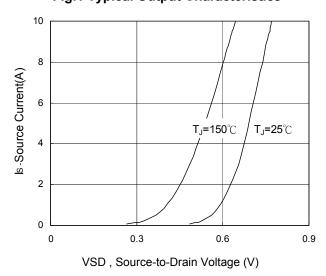


Fig.3 Forward Characteristics Of Reverse

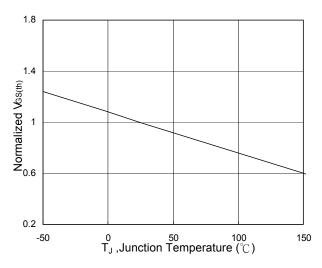


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

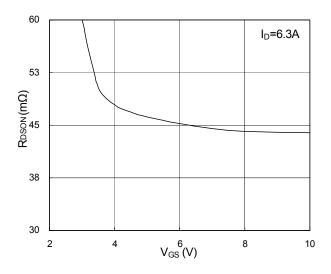


Fig.2 On-Resistance vs. Gate-Source

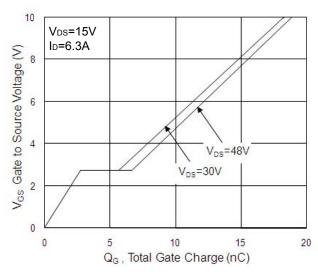


Fig.4 Gate-Charge Characteristics

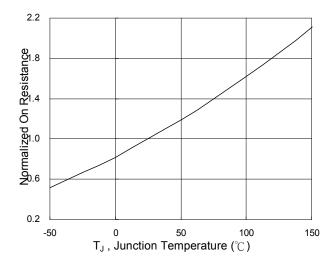
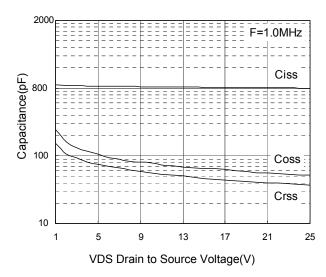


Fig.6 Normalized R_{DSON} vs. T_J



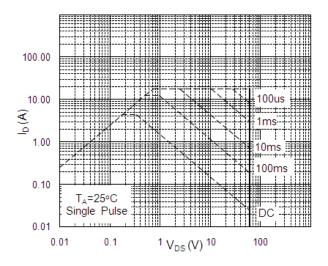


Fig.7 Capacitance

Fig.8 Safe Operating Area

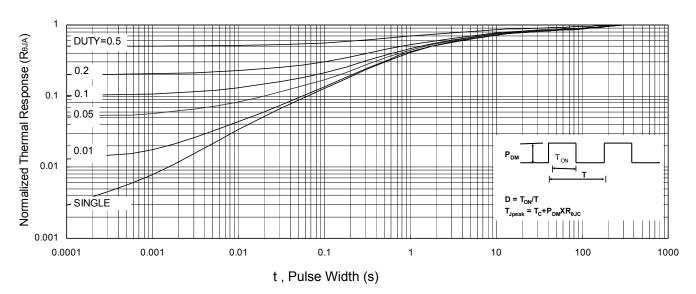


Fig.9 Normalized Maximum Transient Thermal Impedance

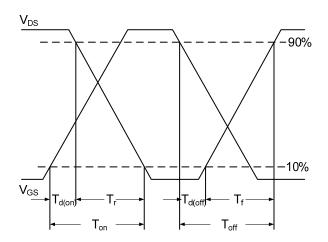


Fig.10 Switching Time Waveform

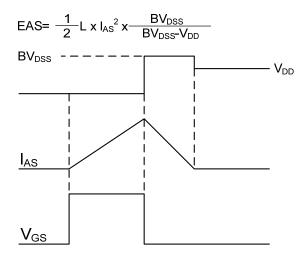


Fig.11 Unclamped Inductive Switching Waveform



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